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LIST OF REFERENCES CITED BY APPLICANT					Shigeo MURAMAT		SU, et al.	
				FILING DATE		GROUP 20		
					HEREWITH		200	
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL			DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
Ka	2	AA	5,774,305	06/30/98	Zine-Eddine, BOUTAGHOU			
		AB						
		AC						
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				FOI	REIGN PATENT DOCUMENTS			
	DOCUMENT DUMBER		DATE	COUNTRY		TRANSLATION YES NO		
K	7	AO	10-198935	07/31/98	JAPAN (with English Abstract)		TEC	x
		AP	2000-30233	01/28/00	JAPAN (with English Abstract)			x
		AQ	11-250434	09/17/99	JAPAN (with English Abstract)			. X
		AR	11-238218	08/31/99	JAPAN (with English Abstract)			X
		AS	11-86253	03/30/99	JAPAN (with English Abstract)			X
		AT	10-222941	08/21/98	JAPAN (with English Abstract)			X
		AU	8-255449	10/01/96	JAPAN (with English Abstract)			X
N)	2	AV	7-262541	10/13/95	JAPAN (with English Abstract)			×
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
AW								
	AX							
	AY							
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MAN				n		Additional References sheet(s) attached		
								5/28/04
*Examiner: Initial if reference is considered, whethere not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								
PRIMARY EXAMINER								